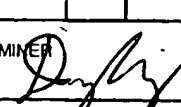


Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2412		SERIAL NO. PRIORITY: 10/300,175		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Micron Technology, Inc.				
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U.S. PATENT DOCUMENTS								
*Examiner's Initials	Class	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
DM	AA	4,253,162	02/1981	Hollingsworth	365	175		
DM	AB	4,849,366	07/1989	Hsu et al.	437	42		
DM	AC	4,995,001	02/1991	Dawson et al.	365	154		
DM	AD	5,153,852	10/1992	Terrell	365	154		
DM	AE	5,182,810	01/1993	Bartling et al.	395	750		
DM	AF	5,239,502	08/1993	Carlstedt	365	154		
DM	AG	5,287,301	02/1994	Redgrave	365	154		
DM	AH	5,307,142	04/1994	Corbett et al.	365	156		
DM	AI	5,426,614	06/1995	Harward	365	225.7		
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
DM	AJ	59-227087	12/1984	Japan				
DM	AK	63-166260	07/1988	Japan				
	AL							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
	AM							
	AN							
	AO							
EXAMINER		DATE CONSIDERED						
		9/28/04						
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U.S. PATENT DOCUMENTS							
*Examiner's Initials	AA	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
DM	AA	5,896,336	04/1999	McClure	365	205	
DM	AB	5,535,166	07/1996	Bateman	365	208	
DM	AC	5,949,706	09/1999	Chang et al.	365	156	
DM	AD	6,081,464	06/2000	Marr	365	201	
DM	AE	6,103,579	08/2000	Violette	438	279	
DM	AF	6,383,848	05/2002	Violette	438	142	
DM	AG	6,301,148	10/2001	Violette	365	156	
DM	AH	3,967,988	07/1976	Davidsohn	148	187	
DM	AI	4,661,831	04/1987	Schmitt-Landsiedel et al.	357	46	

FOREIGN PATENT DOCUMENTS								
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	AK							
	AL							

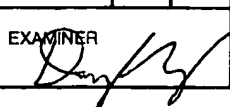
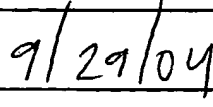
  

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)		
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EXAMINER <i>Duffy</i>	DATE CONSIDERED <i>9/29/04</i>
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				FILING DATE PRIORITY: 11/19/2002		GROUP PRIORITY: 2824		
<b>U.S. PATENT DOCUMENTS</b>								
*Examiner's Initials	AA	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
DM	AA	4,823,319	04/1989	Pfennings	365	189		
DM	AB	5,097,448	03/1992	Segawa	365	200		
	AC							
	AD							
	AE							
	AF							
	AG							
	AH							
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<b>FOREIGN PATENT DOCUMENTS</b>								
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